

TOSHIBA Diode Silicon Epitaxial Planar Type

## 1SS181

## Ultra High Speed Switching Application

- Small package : SC-59
- Low forward voltage :  $V_F(3) = 0.92V$  (Typ.)
- Fast reverse recovery time:  $t_{rr} = 1.6ns$  (Typ.)
- Small total capacitance :  $C_T = 2.2pF$  (Typ.)

Absolute Maximum Ratings ( $T_a = 25^\circ C$ )

| Characteristic                 | Symbol    | Rating  | Unit       |
|--------------------------------|-----------|---------|------------|
| Maximum (peak) reverse voltage | $V_{RM}$  | 85      | V          |
| Reverse voltage                | $V_R$     | 80      | V          |
| Maximum (peak) forward current | $I_{FM}$  | 300 (*) | mA         |
| Average forward current        | $I_O$     | 100 (*) | mA         |
| Surge current (10ms)           | $I_{FSM}$ | 2 (*)   | A          |
| Power dissipation              | P         | 150     | mW         |
| Junction temperature           | $T_j$     | 125     | $^\circ C$ |
| Storage temperature            | $T_{stg}$ | -55~125 | $^\circ C$ |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

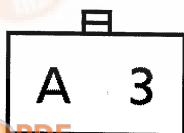
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

\*: Unit rating. Total rating = Unit rating  $\times$  1.5.

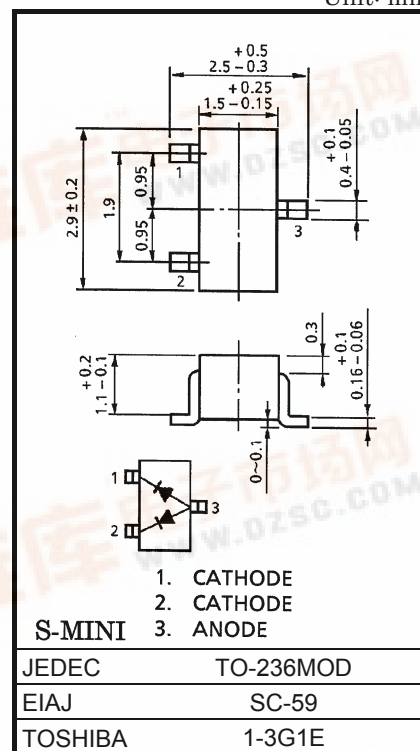
## Electrical Characteristics

| Characteristic        | Symbol   | Test Circuit | Test Condition       | Min | Typ. | Max  | Unit    |
|-----------------------|----------|--------------|----------------------|-----|------|------|---------|
| Forward voltage       | $V_F(1)$ | —            | $I_F = 1mA$          | —   | 0.61 | —    | V       |
|                       | $V_F(2)$ | —            | $I_F = 10mA$         | —   | 0.74 | —    |         |
|                       | $V_F(3)$ | —            | $I_F = 100mAs$       | —   | 0.92 | 1.20 |         |
| Reverse current       | $I_R(1)$ | —            | $V_R = 30V$          | —   | —    | 0.1  | $\mu A$ |
|                       | $I_R(2)$ | —            | $V_R = 80V$          | —   | —    | 0.5  |         |
| Total capacitance     | $C_T$    | —            | $V_R = 0, f = 1MHz$  | —   | 2.2  | 4.0  | pF      |
| Reverse recovery time | $t_{rr}$ | —            | $I_F = 10mA$ (Fig.1) | —   | 1.6  | 4.0  | ns      |

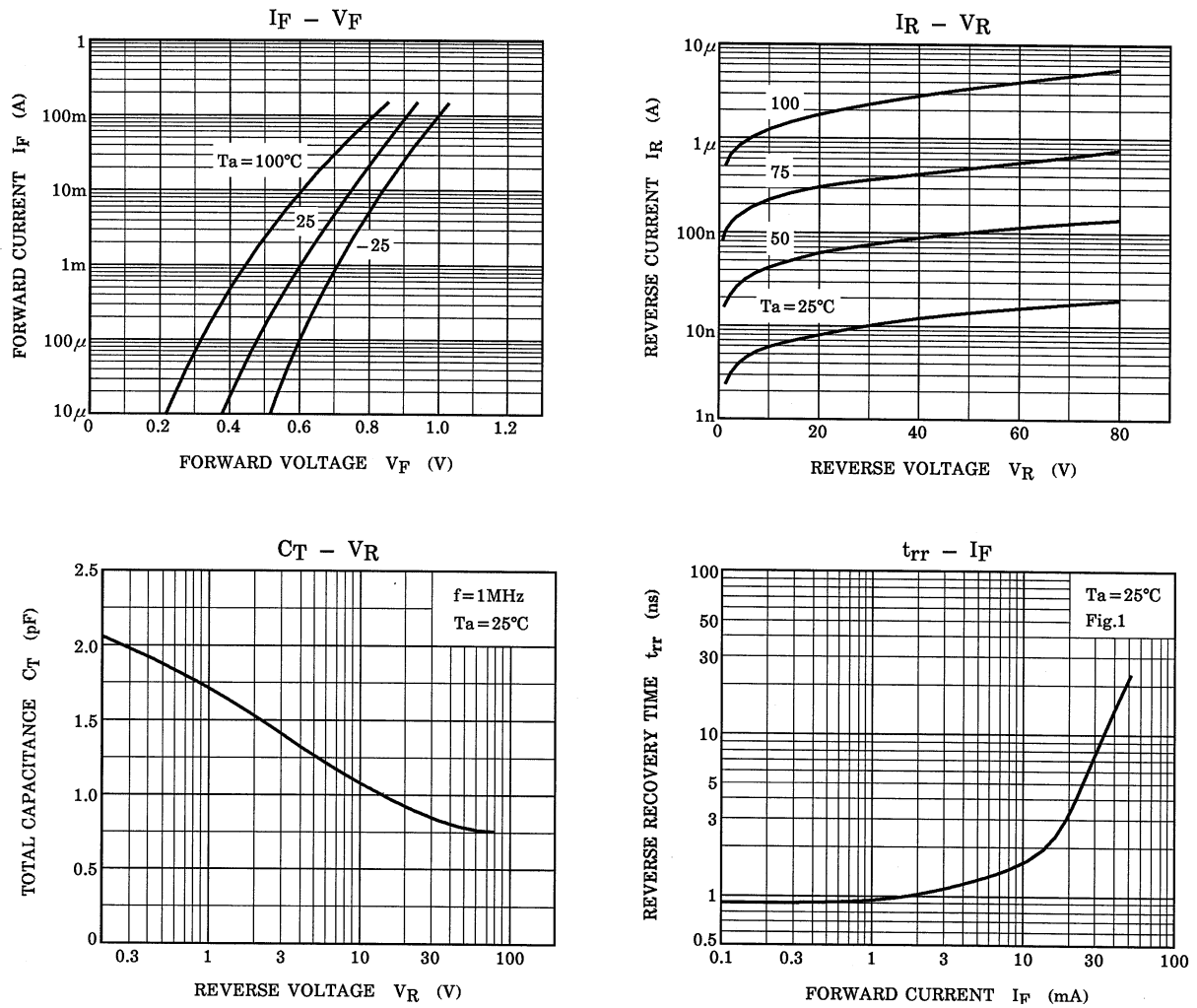
## Marking



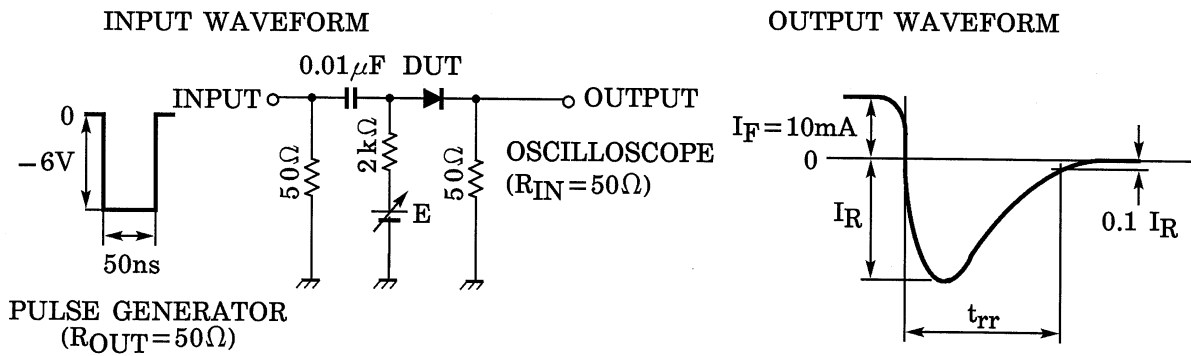
Unit: mm



Weight: 0.012g



**Fig.1 Reverse recovery time ( $t_{rr}$ ) test circuit**



**RESTRICTIONS ON PRODUCT USE**

20070701-EN GENERAL

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- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.  
In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc.
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